Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/667,316	HAYASHI ET AL.	
Examiner	Art Unit	
Anh T.N. Vo	2861	

SEARCHED							
Class	Subclass	Date	Examiner				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
347	86	7/142006	pp	
	49			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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